PTP23N10A

100V N-Channel MOSFET

General Features

- \triangleright Proprietary New Planar Technology
- \triangleright
- $R_{DS(ON),typ}$ =17m Ω @V_{GS}=10V Low Gate Charge Minimize Switching Loss \triangleright
- Fast Recovery Body Diode D

Applications ≻ Automotive

- DC Motor Control

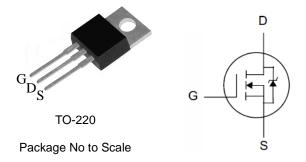
Ordering Information

Part Number	Package	Brand
PTP23N10A	TO-220	ï

Absolute Maximum Ratings

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(P6)	Lead Free	Package	and Finish
V	Loudinoo	1 uonago	

BV _{DSS}	R _{DS(ON),typ} .	I _D
100V	17mΩ	57A



 $T_C{=}25\,^\circ\!\mathrm{C}$ unless otherwise specified

Symbol	Parameter	PTP23N10A	Unit	
V _{DSS}	Drain-to-Source Voltage	100	V	
V _{GSS}	Gate-to-Source Voltage	±20	V	
I _D	Continuous Drain Current	57	A	
I _{DM}	Pulsed Drain Current at V _{GS} =10V	Figure 6	A	
E _{AS}	Single Pulse Avalanche Energy	1000	mJ	
D	Power Dissipation	200	W	
P _D	Derating Factor above 25°C	1.3	W/℃	
TL	TLSoldering Temperature Distance of 1.6mm from case for 10 seconds300		°C	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 175	C	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTP23N10A	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	0.75	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	°CNW

Electrical Characteristics

OFF Characteristics $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	100			V	V_{GS} =0V, I _D =250uA
	1		V _{DS} =100V, V _{GS} =0V			
I _{DSS}	Drain-to-Source Leakage Current			100	uA	V _{DS} =80V, V _{GS} =0V, T _J =125℃
	Cata ta Sauraa Laakaga Currant			+100	-	V_{GS} =+20V, V_{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	nA	V _{GS} =-20V, V _{DS} =0V

ON Characteristics

ON Characteristics				$T_J = 25^{\circ}C$ unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		17	23	mΩ	V _{GS} =10V, I _D =28A
V _{GS(TH)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}, I_{D}=250uA$
gfs	Forward Transconductance		85		S	VDS=15V,ID=28A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		2700			\/0\/
C _{rss}	Reverse Transfer Capacitance		260		pF	V _{GS} =0V, V _{DS} =25V, f=1.0MH _Z
C _{oss}	Output Capacitance		610			
Qg	Total Gate Charge		105			
Q _{gs}	Gate-to-Source Charge		15		nC	V_{DD} =50V, I _D =28A, V _{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		45			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		20			
trise	Rise Time		28		~ 6	V _{DD} =50V, I _D =28A,
td(OFF)	Turn-Off Delay Time		65		nS	V _{GS} = 10V Rg=2.5Ω
tfall	Fall Time		15			

Source-Drain Body Diode Characteristics

 $T_J=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			57	A	Integral PN-diode in MOSFET
I _{SM}	Pulsed Source Current ^[2]			230		
V _{SD}	Diode Forward Voltage			1.5	V	I _S =28A, V _{GS} =0V
trr	Reverse recovery time		195		ns	IF=28A,
Qrr	Reverse recovery charge		107		nC	di⊧/dt=100Å/µs

Note:

- [1] T_J=+25℃ to +150℃
- [2] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

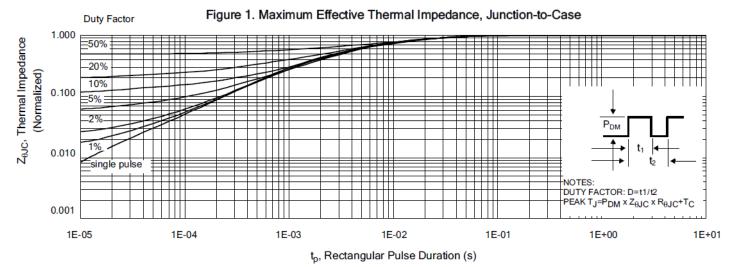


Figure 2. Maximum Power Dissipation vs Case Temperature

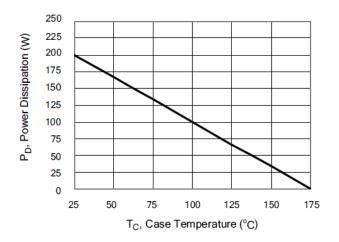


Figure 4. Typical Output Characteristics

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V_{DS}, Drain-to-Source Voltage (V)

GS = 15V

/cs = 10V

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PULSE DURATION = 10 uS

DUTY FACTOR = 0.5% MAX

V_{GS} = 8V

V_{GS} = 7V

V_{GS} = 6V

VGS = 5V

15

/gs = 5.5V

20

T_C = 25 °C

105

90

75

60

45

30

15

0

0

I_D, Drain Current (A)

Figure 3. Maximum Continuous Drain Current vs Case Temperature

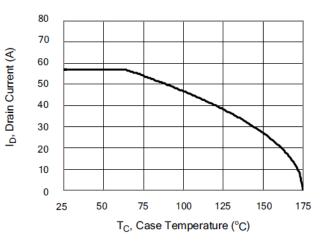
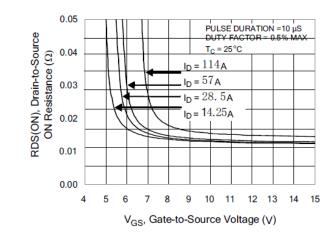


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



Typical Characteristics(Cont.)

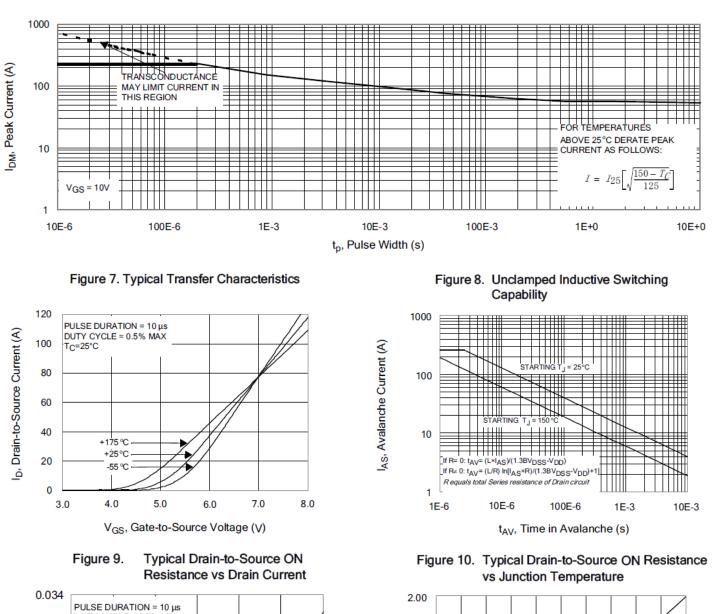
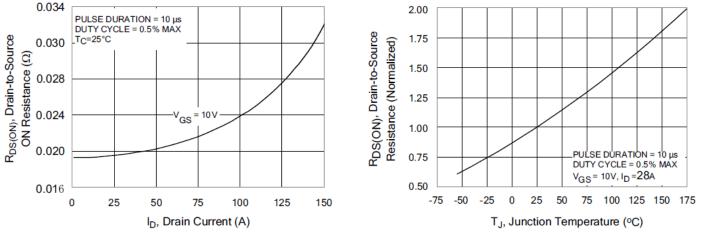
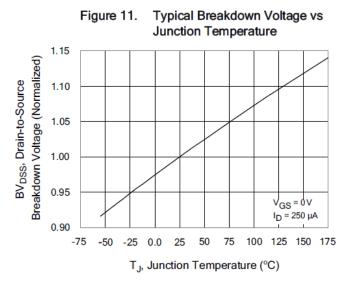


Figure 6. Maximum Peak Current Capability

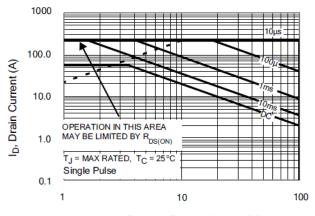




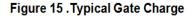
Typical Characteristics(Cont.)

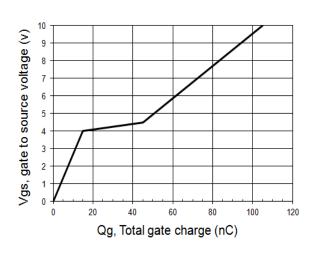


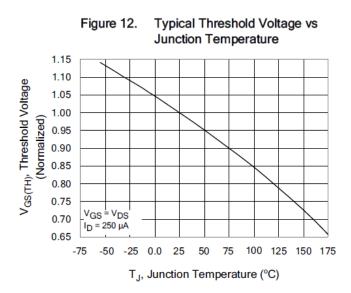


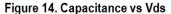


V_{DS}, Drain-to-Source Voltage (V)









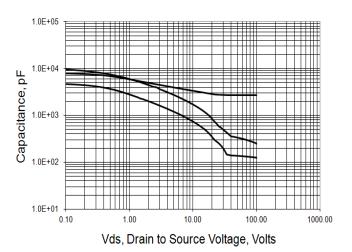
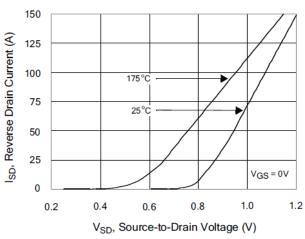


Figure 16. Typical Body Diode Transfer Characteristics



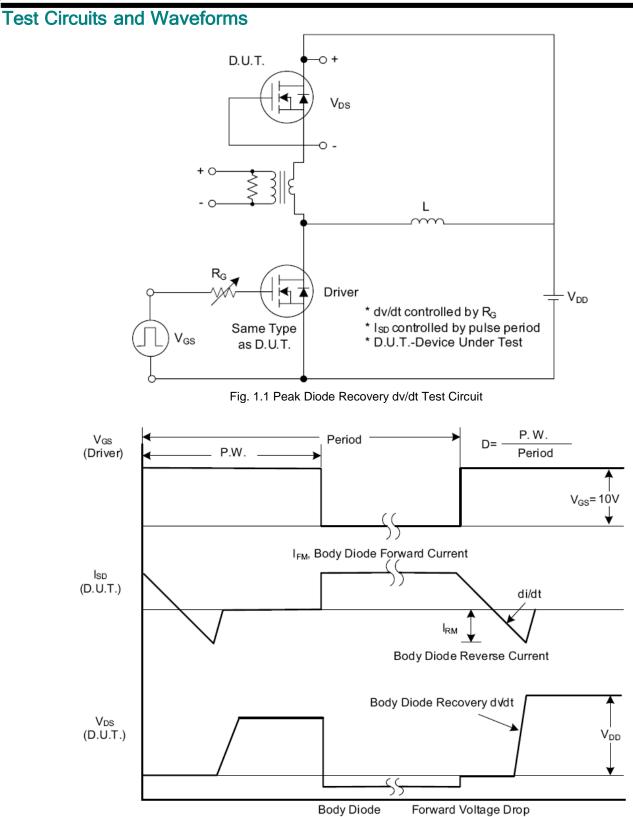
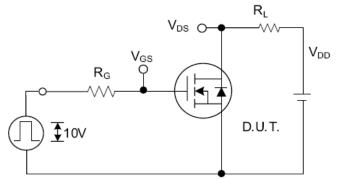


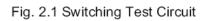
Fig. 1.2 Peak Diode Recovery dv/dt Waveforms

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PTP23N10A

Test Circuits and Waveforms (Cont.)





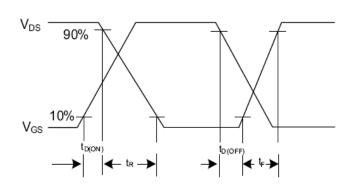


Fig. 2.2 Switching Waveforms

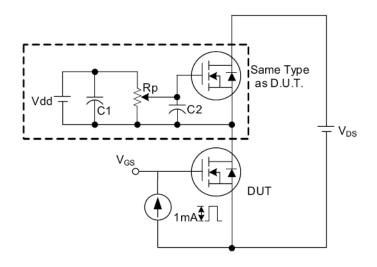


Fig. 3 . 1 Gate Charge Test Circuit

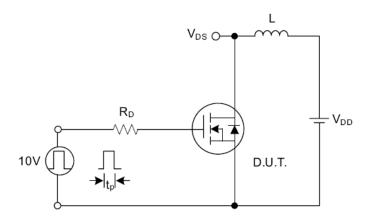


Fig. 4.1 Unclamped Inductive Switching Test Circuit

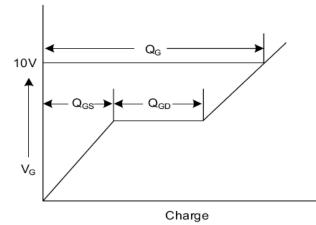
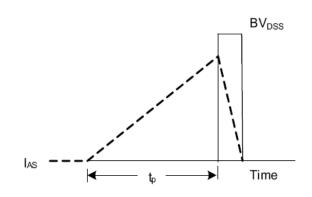


Fig. 3.2 Gate Charge Waveform







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